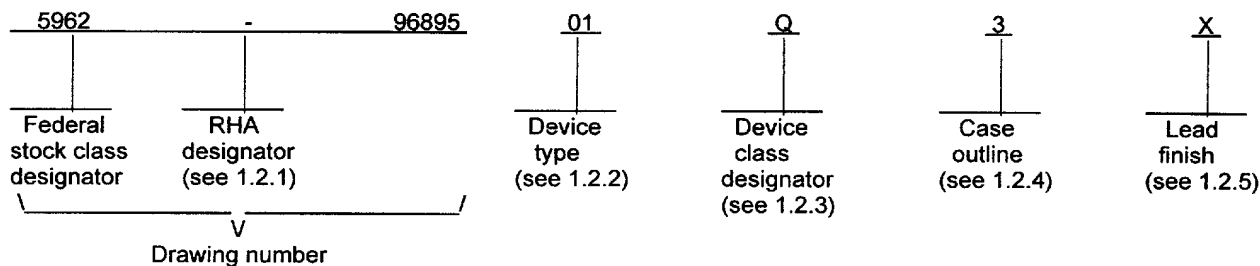


1. SCOPE

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Scope - This drawing documents two product assurance class levels consisting of high reliability (device classes Q and M) and space application (device class V). A choice of case outlines and lead finishes are available and are reflected in the Part or Identifying Number (PIN). When available, a choice of Radiation Hardness Assurance (RHA) levels are reflected in the PIN.

1.2 PIN. The PIN is as shown in the following example:



1.2.1 RHA designator. Device classes Q and V RHA marked devices meet the MIL-PRF-38535 specified RHA levels and are marked with the appropriate RHA designator. Device class M RHA marked devices meet the MIL-PRF-38535, appendix A specified RHA levels and are marked with the appropriate RHA designator. A dash (-) indicates a non-RHA device.

1.2.2 Device type(s). The device type(s) identify the circuit function as follows:

<u>Device type</u>	<u>Generic number</u>	<u>Circuit function</u>
01	7B923	High-speed optical/copper transmitter interface

1.2.3 Device class designator. The device class designator is a single letter identifying the product assurance level as follows:

<u>Device class</u>	<u>Device requirements documentation</u>
M	Vendor self-certification to the requirements for MIL-STD-883 compliant, non-JAN class level B microcircuits in accordance with MIL-PRF-38535, appendix A
Q or V	Certification and qualification to MIL-PRF-38535

1.2.4 Case outline(s). The case outline(s) are as designated in MIL-STD-1835 and as follows:

<u>Outline letter</u>	<u>Descriptive designator</u>	<u>Terminals</u>	<u>Package style</u>
3	CQCC2-N28	28	Square leadless chip carrier

1.2.5 Lead finish. The lead finish is as specified in MIL-PRF-38535 for device classes Q and V or MIL-PRF-38535, appendix A for device class M.

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1.3 Absolute maximum ratings. 1/

Supply voltage range (V_{CC}) to ground potential continuous	-----	-0.5 V to +7.0 V
DC voltage range applied to output	-----	-0.5 V to V_{CC} maximum
DC input voltage range	-----	-0.5 V to +7.0 V
DC output current (TTL LOW)	-----	30 mA
DC output current (PECL HIGH)	-----	-50 mA
DC input current	-----	-30 to +0.5 mA
Storage temperature range	-----	-65°C to +150°C
Maximum power dissipation (P_D) 2/	-----	1.0 W
Lead temperature (soldering, 10 seconds)	-----	260°C
Thermal resistance, Junction to case (θ_{JC})	-----	See MIL-STD-1835
Junction temperature (T_J)	-----	155°C

1.4 Recommended operating conditions.

Supply voltage range (V_{CC})	-----	+4.5 V dc to +5.5 V dc
Minimum high-level input voltage (V_{IH}) (CKW and FOTO)	-----	2.2 V
(Others)	-----	2.0 V
Maximum low-level input voltage (V_{IL})	-----	0.8 V
Case operating temperature range	-----	-55°C to +125°C

1.5 Digital logic testing for device classes Q and V.

Fault coverage measurement of manufacturing logic tests (MIL-STD-883, test method 5012)	-----	XX percent 3/
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2. APPLICABLE DOCUMENTS

2.1 Government specification, standards, and handbooks. The following specification, standards, and handbooks form a part of this drawing to the extent specified herein. Unless otherwise specified, the issues of these documents are those listed in the issue of the Department of Defense Index of Specifications and Standards (DoDISS) and supplement thereto, cited in the solicitation.

SPECIFICATION

MILITARY

MIL-PRF-38535 - Integrated Circuits, Manufacturing, General Specification for.

STANDARDS

MILITARY

MIL-STD-883 - Test Methods and Procedures for Microelectronics.
MIL-STD-973 - Configuration Management.
MIL-STD-1835 - Microcircuit Case Outlines.

- 1/ Stresses above the absolute maximum rating may cause permanent damage to the device. Extended operation at the maximum levels may degrade performance and affect reliability.
2/ Must withstand the added P_D due to short circuit test; e.g., I_{SC} .
3/ Values will be added when they become available.

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HANDBOOKS

[查询"5962-9689501Q3A"供应商](#)

- MIL-HDBK-103 - List of Standard Microcircuit Drawings (SMD's).
- MIL-HDBK-780 - Standard Microcircuit Drawings.

(Unless otherwise indicated, copies of the specification, standards, and handbooks are available from the Standardization Document Order Desk, 700 Robbins Avenue, Building 4D, Philadelphia, PA 19111-5094.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing takes precedence. Nothing in this document, however, supersedes applicable laws and regulations unless a specific exemption has been obtained.

3. REQUIREMENTS

3.1 Item requirements. The individual item requirements for device classes Q and V shall be in accordance with MIL-PRF-38535 and as specified herein or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein. The individual item requirements for device class M shall be in accordance with MIL-PRF-38535, appendix A for non-JAN class level B devices and as specified herein.

3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-PRF-38535 and herein for device classes Q and V or MIL-PRF-38535, appendix A and herein for device class M.

3.2.1 Case outline(s). The case outline(s) shall be in accordance with 1.2.4 herein .

3.2.2 Terminal connections. The terminal connections shall be as specified on figure 1 .

3.2.3 Truth table(s). The truth table(s) shall be as specified on figure 2.

3.2.4 Functional block diagram(s). The functional block diagram(s) shall be as specified on figure 3.

3.2.5 Radiation exposure circuit. The radiation exposure circuit shall be as specified when available.

3.3 Electrical performance characteristics and postirradiation parameter limits. Unless otherwise specified herein, the electrical performance characteristics and postirradiation parameter limits are as specified in table I and shall apply over the full case operating temperature range.

3.4 Electrical test requirements. The electrical test requirements shall be the subgroups specified in table II. The electrical tests for each subgroup are defined in table I.

3.5 Marking. The part shall be marked with the PIN listed in 1.2 herein. In addition, the manufacturer's PIN may also be marked as listed in MIL-HDBK-103. For packages where marking of the entire SMD PIN number is not feasible due to space limitations, the manufacturer has the option of not marking the "5962-" on the device. For RHA product using this option, the RHA designator shall still be marked. Marking for device classes Q and V shall be in accordance with MIL-PRF-38535. Marking for device class M shall be in accordance with MIL-PRF-38535, appendix A.

3.5.1 Certification/compliance mark. The certification mark for device classes Q and V shall be a "QML" or "Q" as required in MIL-PRF-38535. The compliance mark for device class M shall be a "C" as required in MIL-PRF-38535, appendix A.

3.6 Certificate of compliance. For device classes Q and V, a certificate of compliance shall be required from a QML-38535 listed manufacturer in order to supply to the requirements of this drawing (see 6.6.1 herein). For device class M, a certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in MIL-HDBK-103 (see 6.6.2 herein). The certificate of compliance submitted to DSCC-VA prior to listing as an approved source of supply for this drawing shall affirm that the manufacturer's product meets, for device classes Q and V, the requirements of MIL-PRF-38535 and herein or for device class M, the requirements of MIL-PRF-38535, appendix A and herein.

3.7 Certificate of conformance. A certificate of conformance as required for device classes Q and V in MIL-PRF-38535 or for device class M in MIL-PRF-38535, appendix A shall be provided with each lot of microcircuits delivered to this drawing.

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TABLE I. Electrical performance characteristics.

Test Symbol	Conditions -55°C ≤ T _C ≤ +125°C 4.5 V ≤ V _{CC} ≤ 5.5 V 1/ unless otherwise specified	Group A subgroups	Device type	Limits		Unit
				Min	Max	
Bus interface signals: D ₀₋₇ , SC/D, SVS, RP, CKW, ENA, ENN, FOTO, BTSTEN						
Output high voltage	V _{OHT}	V _{CC} = 4.5 V, I _{OH} = -2 mA V _{IN} = 0.0 V or 3.0 V	1, 2, 3	All	2.4	V
Output low voltage	V _{OLT}	V _{CC} = 4.5 V, I _{OH} = 4 mA V _{IN} = 0.0 V or 3.0 V	1, 2, 3	All		0.45 V
Output short circuit current	I _{OST}	V _{OUT} = 0 V 2/	1, 2, 3	All	-15	-90 mA
Input high voltage	V _{IHT}	CKW and FOTO	1, 2, 3	All	2.2	V _{CC}
		all other signals			2.0	V _{CC}
Input low voltage	V _{ILT}		1, 2, 3	All	-0.5	0.8 V
Input high current	I _{IHT}	V _{IN} = V _{CC}	1, 2, 3	All	-10	+10 μA
Input low current	I _{ILT}	V _{IN} = 0.0 V	1, 2, 3	All		-500 μA
PECL interface signals: OUTA+, OUTA-, OUTB+, OUTB-, OUTC+, OUTC-						
Output high voltage	V _{OHE}	Load = 50 Ω to V _{CC} - 2 V	1, 2, 3	All	V _{CC} -1.05	V _{CC} -1.83 V
Output low voltage	V _{OLE}	Load = 50 Ω to V _{CC} - 2 V	1, 2, 3	All	V _{CC} -1.96	V _{CC} -1.62 V
Output differential voltage	V _{ODIF}	Load = 50 Ω to V _{CC} - 2 V	1, 2, 3	All	0.6	V
Miscellaneous: V _{CCN} , V _{CCQ}						
Power supply current 3/	I _{CCT}	Frequency = max	1, 2, 3	All	75	95 mA
Input capacitance	C _{IN}	f _o = 1 MHz, V _{CC} = 5.0 V See 4.4.1b	4	All		10 pF
Functional test		See 4.4.1c	7, 8	All		

See footnotes at end of table.

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TABLE I. Electrical performance characteristics - Continued.

Test	Symbol	Conditions -55°C ≤ T _C ≤ +125°C 4.5 V ≤ V _{CC} ≤ 5.5 V 1/ unless otherwise specified	Group A subgroups	Device type	Limits		Unit
					Min	Max	
Write clock cycle	t ₁		9, 10, 11	All	30.3	62.5	ns
Bit time	t ₂	Internal bit clock 4/ 5/	9, 10, 11	All	3.03	6.25	ns
Write clock high pulse	t ₃		9, 10, 11	All	6.5		ns
Write clock low pulse	t ₄		9, 10, 11	All	6.5		ns
Data set-up time	t ₅	6/	9, 10, 11	All	5.0		ns
Data hold time	t ₆	6/	9, 10, 11	All	0.0		ns
Enable set-up time (to insure correct RP)	t ₇	7/	9, 10, 11	All	6t ₂ +8		ns
Enable hold time (to insure correct RP)	t ₈	7/	9, 10, 11	All	0.0		ns
Read pulse rise alignment	t ₉	8/	9, 10, 11	All	-4	2	ns
Read pulse high	t ₁₀	8/	9, 10, 11	All	4t ₂ -3		ns
Read pulse fall alignment	t ₁₁	8/	9, 10, 11	All	6t ₂ -3		ns
PECL output rise time	t ₁₂	20-80%, PECL test load 4/	9, 10, 11	All		1.2	ns
PECL output fall time	t ₁₃	20-80%, PECL test load 4/	9, 10, 11	All		1.2	ns
Deterministic jitter (peak-peak)	t ₁₄	4/ 9/	9, 10, 11	All		35	ps
Random jitter (peak-peak)	t ₁₅	4/ 10/	9, 10, 11	All		175	ps
Random jitter (σ)	t ₁₆	4/ 10/	9, 10, 11	All		20	ps

See footnotes at end of table.

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TABLE I. Electrical performance characteristics - Continued.

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1/ Unless otherwise specified, for ac test parameters, all test conditions shall be worst case conditions; $V_{IH} = 2.0$ V and $V_{IL} = 0.8$ V. For ac test parameters, all tests are performed using the input waveforms in figure 4. The following conditions also apply:

All timing references are made with respect to +1.5 V for TTL-level signals or to the 50% point between V_{OH} and V_{OL} for PECL levels. PECL input rise and fall times must be < 1 ns between the 20% and 80% points. TTL input rise and fall time must be < 1 ns between 1 V and 2 V points.

- 2/ Tested one output at a time, output shorted for less than one second, less than 10% duty cycle.
- 3/ Maximum I_{CCT} is measured with $V_{CC} = \text{max}$, one PECL output pair loaded with 50Ω to $V_{CC} - 2$ V, and other PECL outputs tied to V_{CC} . I_{CCT} includes current into V_{CCQ} only. Current into V_{CCN} is determined by PECL load currents, typically 30 mA with 50Ω to $V_{CC} - 2$ V loads. When calculating the contribution of PECL load currents to chip power dissipation, the output load current should be multiplied by 1V instead of V_{CC} .
- 4/ Tested initially and after any design or process change that may affect these parameters, but not 100% tested. Not included in production and Group A testing. Supporting data on file to validate limit.
- 5/ Transmitter bit time (t_2) is an internal clock that cannot be directly measured. It is calculated as $t_1/10$. The byte rate is one tenth the bit rate.
- 6/ Data includes D_{0-7} , SC/D , SVS , ENA , ENN , and $BTSTEN$. t_5 and t_6 minimum timing assures correct data load on the rising edge of CKW , but not correct RP function or timing.
- 7/ t_7 and t_8 timing insures correct RP function and correct data load on the rising edge of CKW .
- 8/ Loading on RP is the standard ac TTL test load as shown in figure 4, except that $C_L = 15$ pF.
- 9/ While sending continuous K28.5s, RP unloaded, outputs loaded to $V_{CC} - 2.0$ V, over the operating range.
- 10/ While sending continuous K28.7s after 100,000 samples measured at the cross point of differential outputs, time referenced to the CKW input, over the operating range.

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Decice type	All	Device type	All	Device type	All	Device type	All
Case outline	3	Case outline	3	Case outline	3	Case outline	3
Terminal number	Terminal symbol	Terminal number	Terminal symbol	Terminal number	Terminal symbol	Terminal number	Terminal symbol
1	OUTB-	8	RP	15	D ₃ (D _e)	22	V _{CCQ}
2	OUTC-	9	V _{CCQ}	16	D ₂ (D _d)	23	EN \bar{A}
3	OUTC+	10	SVS (D _j)	17	D ₁ (D _c)	24	ENN
4	V _{CCN}	11	D ₇ (D _h)	18	D ₀ (D _b)	25	FOTO
5	BTSTEN	12	D ₆ (D _g)	19	SC/ \bar{D} (D _a)	26	OUTA-
6	GND	13	D ₅ (D _f)	20	GND	27	OUTA+
7	MODE	14	D ₄ (D _i)	21	CKW	28	OUTB+

FIGURE 1. Terminal connections.

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Data byte name	Bits	Current RD-	Current RD+	Data byte name	Bits	Current RD-	Current RD+
	HGF EDCBA	abcdei fghj	abcdei fghj		HGF EDCBA	abcdei fghj	abcdei fghj
D0.0	000 00000	100111 0100	011000 1011	D0.2	010 00000	100111 0101	011000 0101
D1.0	000 00001	011101 0100	100010 1011	D1.2	010 00001	011101 0101	100010 0101
D2.0	000 00010	101101 0100	010010 1011	D2.2	010 00010	101101 0101	010010 0101
D3.0	000 00011	110001 1011	110001 0100	D3.2	010 00011	110001 0101	110001 0101
D4.0	000 00100	110101 0100	001010 1011	D4.2	010 00100	110101 0101	001010 0101
D5.0	000 00101	101001 1011	101001 0100	D5.2	010 00101	101001 0101	101001 0101
D6.0	000 00110	011001 1011	011001 0100	D6.2	010 00110	011001 0101	011001 0101
D7.0	000 00111	111000 1011	000111 0100	D7.2	010 00111	111000 0101	000111 0101
D8.0	000 01000	111001 0100	000110 1011	D8.2	010 01000	111001 0101	000110 0101
D9.0	000 01001	100101 1011	100101 0100	D9.2	010 01001	100101 0101	100101 0101
D10.0	000 01010	010101 1011	010101 0100	D10.2	010 01010	010101 0101	010101 0101
D11.0	000 01011	110100 1011	110100 0100	D11.2	010 01011	110100 0101	110100 0101
D12.0	000 01100	001101 1011	001101 0100	D12.2	010 01100	001101 0101	001101 0101
D13.0	000 01101	101100 1011	101100 0100	D13.2	010 01101	101100 0101	101100 0101
D14.0	000 01110	011100 1011	011100 0100	D14.2	010 01110	011100 0101	011100 0101
D15.0	000 01111	010111 0100	101000 1011	D15.2	010 01111	010111 0101	101000 0101
D16.0	000 10000	011011 0100	100100 1011	D16.2	010 10000	011011 0101	100100 0101
D17.0	000 10001	100011 1011	100011 0100	D17.2	010 10001	100011 0101	100011 0101
D18.0	000 10010	010011 1011	010011 0100	D18.2	010 10010	010011 0101	010011 0101
D19.0	000 10011	110010 1011	110010 0100	D19.2	010 10011	110010 0101	110010 0101
D20.0	000 10100	001011 1011	001011 0100	D20.2	010 10100	001011 0101	001011 0101
D21.0	000 10101	101010 1011	101010 0100	D21.2	010 10101	101010 0101	101010 0101
D22.0	000 10110	011010 1011	011010 0100	D22.2	010 10110	011010 0101	011010 0101
D23.0	000 10111	111010 0100	000101 1011	D23.2	010 10111	111010 0101	000101 0101
D24.0	000 11000	110011 0100	001100 1011	D24.2	010 11000	110011 0101	001100 0101
D25.0	000 11001	100110 1011	100110 0100	D25.2	010 11001	100110 0101	100110 0101
D26.0	000 11010	010110 1011	010110 0100	D26.2	010 11010	010110 0101	010110 0101
D27.0	000 11011	110110 0100	001001 1011	D27.2	010 11011	110110 0101	001001 0101
D28.0	000 11100	001110 1011	001110 0100	D28.2	010 11100	001110 0101	001110 0101
D29.0	000 11101	101110 0100	010001 1011	D29.2	010 11101	101110 0101	010001 0101
D30.0	000 11110	011110 0100	100001 1011	D30.2	010 11110	011110 0101	100001 0101
D31.0	000 11111	101011 0100	010100 1011	D31.2	010 11111	101011 0101	010100 0101
D0.1	001 00000	100111 1001	011000 1001	D0.3	011 00000	100111 0011	011000 1100
D1.1	001 00001	011101 1001	100010 1001	D1.3	011 00001	011101 0011	100010 1100
D2.1	001 00010	101101 1001	010010 1001	D2.3	011 00010	101101 0011	010010 1100
D3.1	001 00011	110001 1001	110001 1001	D3.3	011 00011	110001 1100	110001 0011
D4.1	001 00100	110101 1001	001010 1001	D4.3	011 00100	110101 0011	001010 1100
D5.1	001 00101	101001 1001	101001 1001	D5.3	011 00101	101001 1100	101001 0011
D6.1	001 00110	011001 1001	011001 1001	D6.3	011 00110	011001 1100	011001 0011
D7.1	001 00111	111000 1001	000111 1001	D7.3	011 00111	111000 1100	000111 0011
D8.1	001 01000	111001 1001	000110 1001	D8.3	011 01000	111001 0011	000110 1100
D9.1	001 01001	100101 1001	100101 1001	D9.3	011 01001	100101 1100	100101 0011
D10.1	001 01010	010101 1001	010101 1001	D10.3	011 01010	010101 1100	010101 0011
D11.1	001 01011	110100 1001	110100 1001	D11.3	011 01011	110100 1100	110100 0011
D12.1	001 01100	001101 1001	001101 1001	D12.3	011 01100	001101 1100	001101 0011
D13.1	001 01101	101100 1001	101100 1001	D13.3	011 01101	101100 1100	101100 0011
D14.1	001 01110	011100 1001	011100 1001	D14.3	011 01110	011100 1100	011100 0011
D15.1	001 01111	010111 1001	101000 1001	D15.3	011 01111	010111 0011	101000 1100
D16.1	001 10000	011011 1001	100100 1001	D16.3	011 10000	011011 0011	100100 1100
D17.1	001 10001	100011 1001	100011 1001	D17.3	011 10001	100011 1100	100011 0011
D18.1	001 10010	010011 1001	010011 1001	D18.3	011 10010	010011 1100	010011 0011
D19.1	001 10011	110010 1001	110010 1001	D19.3	011 10011	110010 1100	110010 0011
D20.1	001 10100	001011 1001	001011 1001	D20.3	011 10100	001011 1100	001011 0011
D21.1	001 10101	101010 1001	101010 1001	D21.3	011 10101	101010 1100	101010 0011
D22.1	001 10110	011010 1001	011010 1001	D22.3	011 10110	011010 1100	011010 0011
D23.1	001 10111	111010 1001	000101 1001	D23.3	011 10111	111010 0011	000101 1100
D24.1	001 11000	110011 1001	001100 1001	D24.3	011 11000	110011 0011	001100 1100
D25.1	001 11001	100110 1001	100110 1001	D25.3	011 11001	100110 1100	100110 0011
D26.1	001 11010	010110 1001	010110 1001	D26.3	011 11010	010110 1100	010110 0011
D27.1	001 11011	110110 1001	001001 1001	D27.3	011 11011	110110 0011	001001 1100
D28.1	001 11100	001110 1001	001110 1001	D28.3	011 11100	001110 1100	001110 0011
D29.1	001 11101	101110 1001	010001 1001	D29.3	011 11101	101110 0011	010001 1100
D30.1	001 11110	011110 1001	100001 1001	D30.3	011 11110	011110 0011	100001 1100
D31.1	001 11111	101011 1001	010100 1001	D31.3	011 11111	101011 0011	010100 1100

FIGURE 2. Truth table.

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Data byte name	Bits		Current RD-		Current RD+		Data byte name	Bits		Current RD-		Current RD+	
	HGF EDCBA	abcdei fghj	abcdei fghj	abcdei fghj	abcdei fghj	abcdei fghj		HGF EDCBA	abcdei fghj	abcdei fghj	abcdei fghj		
D0.4	100	00000	100111	0010	011000	1101	D0.6	110	00000	100111	0110	011000	0110
D1.4	100	00001	011101	0010	100010	1101	D1.6	110	00001	011101	0110	100010	0110
D2.4	100	00010	101101	0010	010010	1101	D2.6	110	00010	101101	0110	010010	0110
D3.4	100	00011	110001	1101	110001	0010	D3.6	110	00011	110001	0110	110001	0110
D4.4	100	00100	110101	0010	001010	1101	D4.6	110	00100	110101	0110	001010	0110
D5.4	100	00101	101001	1101	101001	0010	D5.6	110	00101	101001	0110	101001	0110
D6.4	100	00110	011001	1101	011001	0010	D6.6	110	00110	011001	0110	011001	0110
D7.4	100	00111	111000	1101	000111	0010	D7.6	110	00111	111000	0110	000111	0110
D8.4	100	01000	111001	0010	000110	1101	D8.6	110	01000	111001	0110	000110	0110
D9.4	100	01001	100101	1101	100101	0010	D9.6	110	01001	100101	0110	100101	0110
D10.4	100	01010	010101	1101	010101	0010	D10.6	110	01010	010101	0110	010101	0110
D11.4	100	01011	110100	1101	110100	0010	D11.6	110	01011	110100	0110	110100	0110
D12.4	100	01100	001101	1101	001101	0010	D12.6	110	01100	001101	0110	001101	0110
D13.4	100	01101	101100	1101	101100	0010	D13.6	110	01101	101100	0110	101100	0110
D14.4	100	01110	011100	1101	011100	0010	D14.6	110	01110	011100	0110	011100	0110
D15.4	100	01111	010111	0010	101000	1101	D15.6	110	01111	010111	0110	101000	0110
D16.4	100	10000	011011	0010	100100	1101	D16.6	110	10000	011011	0110	100100	0110
D17.4	100	10001	100011	1101	100011	0010	D17.6	110	10001	100011	0110	100011	0110
D18.4	100	10010	010011	1101	010011	0010	D18.6	110	10010	010011	0110	010011	0110
D19.4	100	10011	110010	1101	110010	0010	D19.6	110	10011	110010	0110	110010	0110
D20.4	100	10100	001011	1101	001011	0010	D20.6	110	10100	001011	0110	001011	0110
D21.4	100	10101	101010	1101	101010	0010	D21.6	110	10101	101010	0110	101010	0110
D22.4	100	10110	011010	1101	011010	0010	D22.6	110	10110	011010	0110	011010	0110
D23.4	100	10111	111010	0010	000101	1101	D23.6	110	10111	111010	0110	000101	0110
D24.4	100	11000	110011	0010	001100	1101	D24.6	110	11000	110011	0110	001100	0110
D25.4	100	11001	100110	1101	100110	0010	D25.6	110	11001	100110	0110	100110	0110
D26.4	100	11010	010110	1101	010110	0010	D26.6	110	11010	010110	0110	010110	0110
D27.4	100	11011	110110	0010	001001	1101	D27.6	110	11011	110110	0110	001001	0110
D28.4	100	11100	001110	1101	001110	0010	D28.6	110	11100	001110	0110	001110	0110
D29.4	100	11101	101110	0010	010001	1101	D29.6	110	11101	101110	0110	010001	0110
D30.4	100	11110	011110	0010	100001	1101	D30.6	110	11110	011110	0110	100001	0110
D31.4	100	11111	101011	0010	010100	1101	D31.6	110	11111	101011	0110	010100	0110
D0.5	101	00000	100111	1010	011000	1010	D0.7	111	00000	100111	0001	011000	1110
D1.5	101	00001	011101	1010	100010	1010	D1.7	111	00001	011101	0001	100010	1110
D2.5	101	00010	101101	1010	010010	1010	D2.7	111	00010	101101	0001	010010	1110
D3.5	101	00011	110001	1010	110001	1010	D3.7	111	00011	110001	1110	110001	0001
D4.5	101	00100	110101	1010	001010	1010	D4.7	111	00100	110101	0001	001010	1110
D5.5	101	00101	101001	1010	101001	1010	D5.7	111	00101	101001	1110	101001	0001
D6.5	101	00110	011001	1010	011001	1010	D6.7	111	00110	011001	1110	011001	0001
D7.5	101	00111	111000	1010	000111	1010	D7.7	111	00111	111000	1110	000111	0001
D8.5	101	01000	111001	1010	000110	1010	D8.7	111	01000	111001	0001	000110	1110
D9.5	101	01001	100101	1010	100101	1010	D9.7	111	01001	100101	1110	100101	0001
D10.5	101	01010	010101	1010	010101	1010	D10.7	111	01010	010101	1110	010101	0001
D11.5	101	01011	110100	1010	110100	1010	D11.7	111	01011	110100	1110	110100	0001
D12.5	101	01100	001101	1010	001101	1010	D12.7	111	01100	001101	1110	001101	0001
D13.5	101	01101	101100	1010	101100	1010	D13.7	111	01101	101100	1110	101100	0001
D14.5	101	01110	011100	1010	011100	1010	D14.7	111	01110	011100	1110	011100	0001
D15.5	101	01111	010111	1010	101000	1010	D15.7	111	01111	010111	0001	101000	1110
D16.5	101	10000	011011	1010	100100	1010	D16.7	111	10000	011011	0001	100100	1110
D17.5	101	10001	100011	1010	100011	1010	D17.7	111	10001	100011	1110	100011	0001
D18.5	101	10010	010011	1010	010011	1010	D18.7	111	10010	010011	1110	010011	0001
D19.5	101	10011	110010	1010	110010	1010	D19.7	111	10011	110010	1110	110010	0001
D20.5	101	10100	001011	1010	001011	1010	D20.7	111	10100	001011	1110	001011	0001
D21.5	101	10101	101010	1010	101010	1010	D21.7	111	10101	101010	1110	101010	0001
D22.5	101	10110	011010	1010	011010	1010	D22.7	111	10110	011010	1110	011010	0001
D23.5	101	10111	111010	1010	000101	1010	D23.7	111	10111	111010	0001	000101	1110
D24.5	101	11000	110011	1010	001100	1010	D24.7	111	11000	110011	0001	001100	1110
D25.5	101	11001	100110	1010	100110	1010	D25.7	111	11001	100110	1110	100110	0001
D26.5	101	11010	010110	1010	010110	1010	D26.7	111	11010	010110	1110	010110	0001
D27.5	101	11011	110110	1010	001001	1010	D27.7	111	11011	110110	0001	001001	1110
D28.5	101	11100	001110	1010	001110	1010	D28.7	111	11100	001110	1110	001110	0001
D29.5	101	11101	101110	1010	010001	1010	D29.7	111	11101	101110	0001	010001	1110
D30.5	101	11110	011110	1010	100001	1010	D30.7	111	11110	011110	0001	100001	1110
D31.5	101	11111	101011	1010	010100	1010	D31.7	111	11111	101011	0001	010100	1110

FIGURE 3. Truth table - Continued.

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Special character byte name <u>5/</u>	Special character code name	Bits		Current RD -	Current RD +
		HGF	EDCBA	abcdei fgjh	abcdei fgjh
Command codes					
K28.0	C0.0 (C00)	000	00000	001111 0100	110000 1011
K28.1	C1.0 (C01)	000	00001	001111 1001	110000 0110
K28.2	C2.0 (C02)	000	00010	001111 0101	110000 1010
K28.3	C3.0 (C03)	000	00011	001111 0011	110000 1100
K28.4	C4.0 (C04)	000	00100	001111 0010	110000 1101
K28.5	C5.0 (C05)	000	00101	001111 1010	110000 0101
K28.6	C6.0 (C06)	000	00110	001111 0110	110000 1001
K28.7	C7.0 (C07)	000	00111	001111 1000	110000 0111
K23.7	C8.0 (C08)	000	01000	111010 1000	000101 0111
K27.7	C9.0 (C09)	000	01001	110110 1000	001001 0111
K29.7	C10.0 (C0A)	000	01010	101110 1000	010001 0111
K30.7	C11.0 (C0B)	000	01011	011110 1000	100001 0111
Sequence generator codes					
Idle <u>9/</u> R RDY <u>10/</u> EOfxx <u>11/</u>	C0.1 (C20)	001	00000	-K28.5, +D21.4, D21.5, D21.5 (repeat)	
	C1.1 (C21)	001	00001	-K28.5, +D21.4, D10.2, D10.2 (repeat)	
	C2.1 (C22)	001	00010	-K28.5, Dnxxx0 +K28.5, Dnxxx1	
Exception codes					
Invalid data <u>12/</u> -K28.5 <u>13/</u> +K28.5 <u>14/</u> Invalid RD <u>15/</u>	C0.7 (CE0)	111	00000	100111 1000	011000 0111
	C1.7 (CE1)	111	00001	001111 1010	001111 1010
	C2.7 (CE2)	111	00010	110000 0101	110000 0101
	C4.7 (CE4)	111	00100	110111 0101	001000 1010

FIGURE 2. Truth table - Continued.

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1/ Coding tables are only used when the transmitter is in Encoded mode (MODE = low).

2/ The notation used for the encoding tables follows that in ANSI X3.230-1994.

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3/ Notation conventions:

- a. Letters are used to represent bit positions within a character.
- b. Capital letters (A, B, C, D, E, F, G, and H) represent the unencoded bit positions of an 8-bit byte.
- c. Lower case letters (a, b, c, d, e, i, f, g, h, and j) represent the encoded bit positions of a 10-bit transmission character.
- d. Bit positions of the unencoded byte are:

Transmitter input - D7 D6 D5 D4 D3 D2 D1 D0
 Letter designator - H G F E D C B A
 MSB LSB

e. Bit positions of the encoded transmission character

Serial data input - j h g f i e d c b a
 MSB LSB

f. Data byte name is a decimal notation based on unencoded character bit groupings.

Note reversed order of bits:

Data Byte - D5.2
 Bit Names - ABCDE FGH
 Bits - 10100 010

4/ Serial transmission characters are transmitted LSB first.

5/ Notation for Special Character byte names is patterned to match that of the data names.

6/ The C7.0, C7.1, and C7.2 special codes are all decoded from the same K28.7 transmission character. A C7.1 will be decoded if the immediately preceding character was a C1.0 (K28.1). A C7.2 will be decoded if the immediately preceding character was a C5.0 (K28.5). A C7.0 will be decoded in all other cases.

Exception codes are used to indicate the detection of errors in the received serial data stream.

- a. A C0.7 indicates that the received 10-bit transmission character did not map to any valid data or special character, of any disparity.
- b. A c1.7 indicates that a valid K28.5 character was received, however the character received had a negative running disparity (RD) when the receiver was expecting a positive RD.
- c. A c2.7 indicates that a valid K28.5 character was received, however the character received had a positive running disparity (RD) when the receiver was expecting a negative RD.
- d. A C4.7 indicates that the received 10-bit transmission character did map to any valid data or special character, however the character disparity was not correct. This may indicate an error in a previous character.

8/ All codes not shown are reserved.

9/ Transmit negative K28.5 (K28.5) disregarding the current running disparity (RD) when input is held for only one byte time. If held longer, transmission begins sending the repeating sequence -K28.5, +D21.4, D21.5, D21.5, (repeat all four bytes)...defined by ANSI Standard X33.230-1994 as the primitive signal known as an "Idle Word". This special character input must be held for four byte times (or integer multiples thereof) or the output sequence will be truncated and replaced by the encoded form of the new data present on the input data bus.

10/ Transmit negative K28.5 (K28.5) disregarding the current running disparity (RD) when input is held for only one byte time. If held longer, transmission begins sending the repeating sequence -K28.5, +D21.4, D10.2, D10.2, (repeat all four bytes)...defined by ANSI Standard X33.230-1994 as the primitive signal known as an "Receiver Ready". (R_RDY). This special character input must be held for four byte times (or integer multiples thereof) or the output sequence will be truncated and replaced by the encoded form of the new data present on the input data bus.

11/ Transmit either a -K28.5 or +K28.5 as determined by the current RD, and modify the following transmission character by setting it's least significant bit to a 1 or 0. If the current RD at the start of the following transmission character is plus (+), the LSB is set to 0, and if the current RD is minus (-), the LSB is set to 1. This modification allows construction of ANSI Standard X3.230-1994 compliant End-Of-Frame (EOF) delimiters wherein the contents of the second byte are determined by the current RD.

12/ Transmit a deliberate code rule violation. The code chosen for this function follows the normal running disparity rules. Transmission of this special character has the same effect as asserting SVS (high).

13/ Transmit a negative K28.5 (-K28.5) disregarding the current RD.

14/ Transmit a positive K28.5 (+28.5) disregarding the current RD.

15/ Transmit a deliberate code violation. The code chosen for this function violates the disparity rules and should indicate a running disparity violation.

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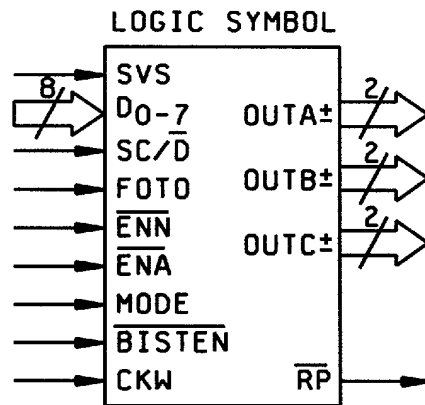
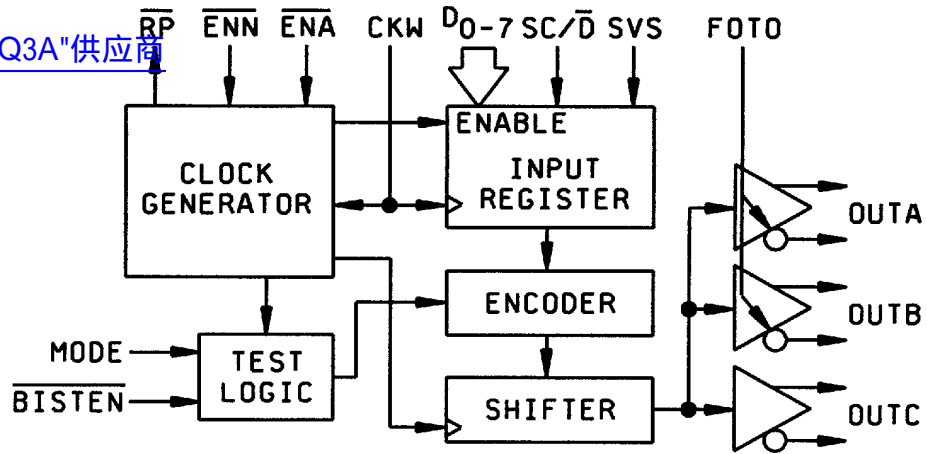



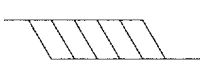
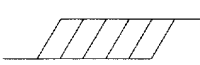
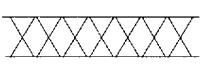
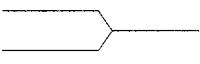
FIGURE 3. Functional block diagram.

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Waveform symbol	Input	Output
	MUST BE VALID	WILL BE VALID
	CHANGE FROM H TO L	WILL CHANGE FROM H TO L
	CHANGE FROM L TO H	WILL CHANGE FROM L TO H
	DON'T CARE ANY CHANGE PERMITTED	CHANGING STATE UNKNOWN
		HIGH IMPEDANCE

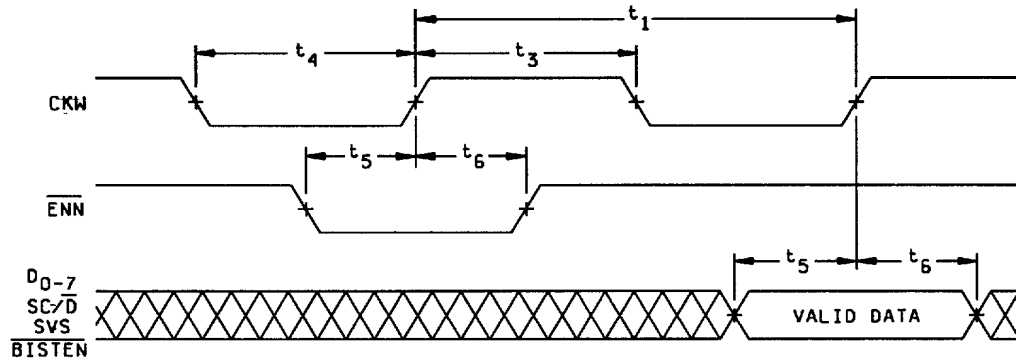


FIGURE 4. Switching waveforms and test circuit.

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■ 9004708 0028845 051 ■

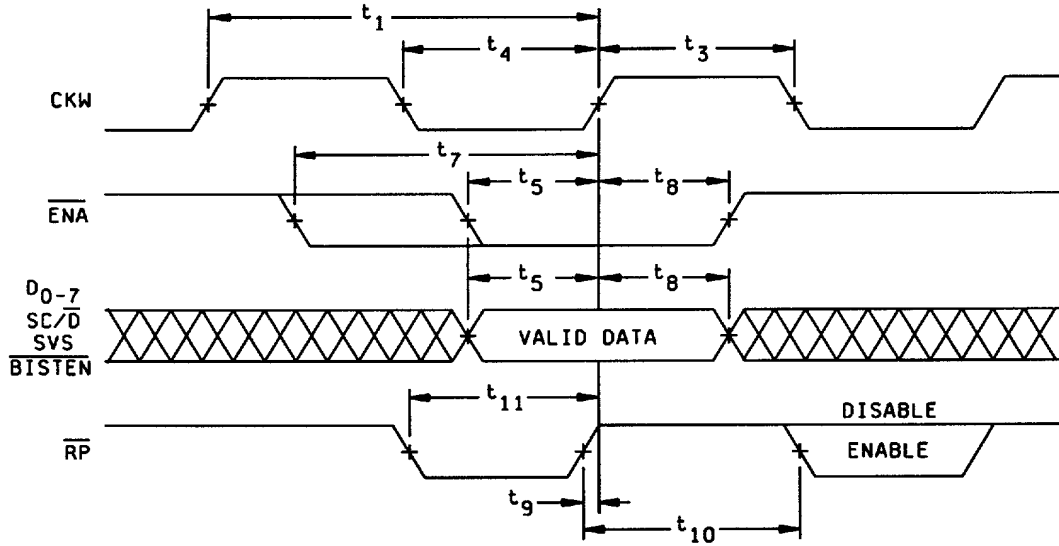
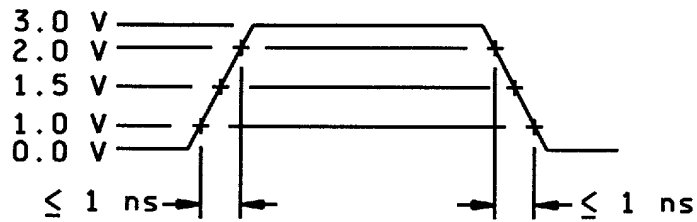
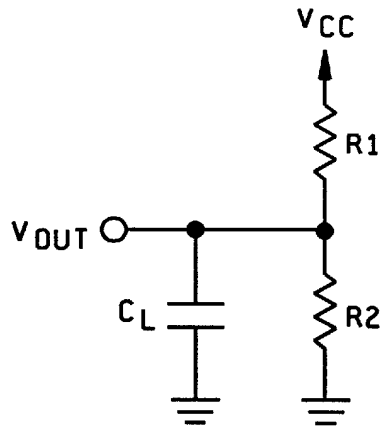


FIGURE 4. Switching waveforms and test circuit - Continued.

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TTL INPUT WAVEFORM
(USED FOR TABLE I AC
ELECTRICAL PERFORMANCE TESTING)



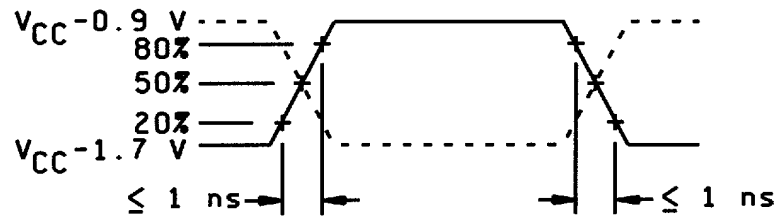
TTL OUTPUT LOAD

NOTES:

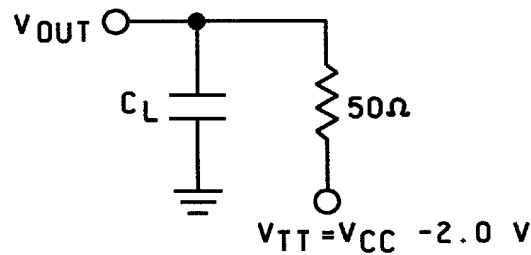
1. $R_1 = 910\Omega$, $R_2 = 510\Omega$.
2. $C_L < 30\text{ pF}$, includes scope probe, wiring and stray capacitance without device in test fixture. Automatic test equipment load configurations and forcing functions are used, therefore this load figure is for reference only.

FIGURE 4. Switching waveforms and test circuit - Continued.

STANDARD MICROCIRCUIT DRAWING DEFENSE SUPPLY CENTER COLUMBUS COLUMBUS, OHIO 43216-5000	SIZE A		5962-96895
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ECL INPUT WAVEFORM
(USED FOR TABLE I AC
ELECTRICAL PERFORMANCE TESTING)



ECL OUTPUT LOAD

NOTES:

$C_L < 5\text{ pF}$, includes scope probe, wiring and stray capacitance without device in test fixture. Automatic test equipment load configurations and forcing functions are used, therefore this load figure is for reference only.

FIGURE 4. Switching waveforms and test circuit - Continued.

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3.8 Notification of change for device class M. For device class M, notification to DSCC-VA of change of product (see 6.2 herein) involving devices acquired to this drawing is required for any change as defined in MIL-STD-973.

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3.9 Verification and review for device class M. For device class M, DSCC, DSCC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.

3.10 Microcircuit group assignment for device class M. Device class M devices covered by this drawing shall be in microcircuit group number 105 (see MIL-PRF-38535, appendix A).

4. QUALITY ASSURANCE PROVISIONS

4.1 Sampling and inspection. For device classes Q and V, sampling and inspection procedures shall be in accordance with MIL-PRF-38535 or as modified in the device manufacturer's Quality Management (QM) plan. The modification in the QM plan shall not affect the form, fit, or function as described herein. For device class M, sampling and inspection procedures shall be in accordance with MIL-PRF-38535, appendix A.

4.2 Screening. For device classes Q and V, screening shall be in accordance with MIL-PRF-38535, and shall be conducted on all devices prior to qualification and technology conformance inspection. For device class M, screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection.

4.2.1 Additional criteria for device class M.

a. Burn-in test, method 1015 of MIL-STD-883.

(1) Test condition C. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to the preparing or acquiring activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1015.

(2) $T_A = +125^\circ\text{C}$, minimum.

b. Interim and final electrical test parameters shall be as specified in table II herein.

4.2.2 Additional criteria for device classes Q and V.

a. The burn-in test duration, test condition and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The burn-in test circuit shall be maintained under document revision level control of the device manufacturer's Technology Review Board (TRB) in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1015 of MIL-STD-883.

b. Interim and final electrical test parameters shall be as specified in table II herein.

c. Additional screening for device class V beyond the requirements of device class Q shall be as specified in MIL-PRF-38535, appendix B.

4.3 Qualification inspection for device classes Q and V. Qualification inspection for device classes Q and V shall be in accordance with MIL-PRF-38535. Inspections to be performed shall be those specified in MIL-PRF-38535 and herein for groups A, B, C, D, and E inspections (see 4.4.1 through 4.4.4).

4.4 Conformance inspection. Technology conformance inspection for classes Q and V shall be in accordance with MIL-PRF-38535 including groups A, B, C, D, and E inspections and as specified herein except where option 2 of MIL-PRF-38535 permits alternate in-line control testing. Quality conformance inspection for device class M shall be in accordance with MIL-PRF-38535, appendix A and as specified herein. Inspections to be performed for device class M shall be those specified in method 5005 of MIL-STD-883 and herein for groups A, B, C, D, and E inspections (see 4.4.1 through 4.4.4).

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4.4.1 Group A inspection.

Tests shall be as specified in table II herein.

- b. Subgroup 4 (C_{IN} measurements) shall be measured only for the initial test and after process or design changes which may affect capacitance. Tests shall be sufficient to validate limits as defined in Table I.
- c. For device class M, subgroups 7 and 8 tests shall be sufficient to verify the truth table. For device classes Q and V, subgroups 7 and 8 shall include verifying the functionality of the device; these tests shall have been fault graded in accordance with MIL-STD-883, test method 5012 (see 1.5 herein).

TABLE II. Electrical test requirements.

Test requirements	Subgroups (in accordance with MIL-STD-883, method 5005, table I)	Subgroups (in accordance with MIL-PRF-38535, table III)	
	Device class M	Device class Q	Device class V
Interim electrical parameters (see 4.2)			
Final electrical parameters (see 4.2)	1/ 1, 2, 3, 7, 8, 9, 10, 11	1/ 1, 2, 3, 7, 8, 9, 10, 11	2/ 1, 2, 3, 7, 8, 9, 10, 11
Group A test requirements (see 4.4)	1, 2, 3, 4, 7, 8, 9, 10, 11	1, 2, 3, 4, 7, 8, 9, 10, 11	1, 2, 3, 4, 7, 8, 9, 10, 11
Group C end-point electrical parameters (see 4.4)	1, 2, 3	1, 2, 3	1, 2, 3
Group D end-point electrical parameters (see 4.4)	1, 2, 3	1, 2, 3	1, 2, 3
Group E end-point electrical parameters (see 4.4)	1, 2, 3	1, 2, 3	1, 2, 3

- 1/ PDA applies to subgroup 1.
- 2/ PDA applies to subgroups 1 and 7.

4.4.2 Group C inspection. The group C inspection end-point electrical parameters shall be as specified in table II herein.

4.4.2.1 Additional criteria for device class M. Steady-state life test conditions, method 1005 of MIL-STD-883:

- a. Test condition C. The test circuit shall be maintained by the manufacturer under document revision level control and shall be made available to the preparing or acquiring activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1005 of MIL-STD-883.
- b. $T_A = +125^\circ\text{C}$, minimum.
- c. Test duration: 1,000 hours, except as permitted by method 1005 of MIL-STD-883.

4.4.2.2 Additional criteria for device classes Q and V. The steady-state life test duration, test condition and test temperature, or approved alternatives shall be as specified in the device manufacturer's QM plan in accordance with MIL-PRF-38535. The test circuit shall be maintained under document revision level control by the device manufacturer's TRB in accordance with MIL-PRF-38535 and shall be made available to the acquiring or preparing activity upon request. The test circuit shall specify the inputs, outputs, biases, and power dissipation, as applicable, in accordance with the intent specified in test method 1005 of MIL-STD-883.

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4.4.3 Group D inspection. The group D inspection end-point electrical parameters shall be as specified in table II herein.

查何"Group E inspection" Group E inspection is required only for parts intended to be marked as radiation hardness assured (see 3.5 herein).

- a. End-point electrical parameters shall be as specified in table II herein.
- b. For device classes Q and V, the devices or test vehicle shall be subjected to radiation hardness assured tests as specified in MIL-PRF-38535 for the RHA level being tested. For device class M, the devices shall be subjected to radiation hardness assured tests as specified in MIL-PRF-38535, appendix A for the RHA level being tested. All device classes must meet the postirradiation end-point electrical parameter limits as defined in table I at $T_A = +25^\circ\text{C} \pm 5^\circ\text{C}$, after exposure, to the subgroups specified in table II herein.
- c. When specified in the purchase order or contract, a copy of the RHA delta limits shall be supplied.

5. PACKAGING

5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-PRF-38535 for device classes Q and V or MIL-PRF-38535, appendix A for device class M.

6. NOTES

6.1 Intended use. Microcircuits conforming to this drawing are intended for use for Government microcircuit applications (original equipment), design applications, and logistics purposes.

6.1.1 Replaceability. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.

6.1.2 Substitutability. Device class Q devices will replace device class M devices.

6.2 Configuration control of SMD's. All proposed changes to existing SMD's will be coordinated with the users of record for the individual documents. This coordination will be accomplished in accordance with MIL-STD-973 using DD Form 1692, Engineering Change Proposal.

6.3 Record of users. Military and industrial users should inform Defense Supply Center Columbus when a system application requires configuration control and which SMD's are applicable to that system. DSCC will maintain a record of users and this list will be used for coordination and distribution of changes to the drawings. Users of drawings covering microelectronic devices (FSC 5962) should contact DSCC-VA, telephone (614) 692-0674.

6.4 Comments. Comments on this drawing should be directed to DSCC-VA, Columbus, Ohio 43216-5000, or telephone (614) 692-0674.

6.5 Abbreviations, symbols, and definitions. The abbreviations, symbols, and definitions used herein are defined in MIL-PRF-38535 and MIL-HDBK-1331, and as follows:

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Symbol	Name and function
D ₀₋₇ (D _{a-h})	Parallel Data Input (TTL input). Data is clocked into the transmitter on the rising edge of CKW if EN \bar{A} is low (or on the next rising CKW with ENN low). If EN \bar{A} and ENN are both high, then a null character (K28.5) is sent. When MODE is high, D _{0, 1, ..., 7} become D _{b, c, ..., h} respectively.
SC/D (D _a)	Special Character/Data Select (TTL input). A HIGH ON SC/D when CKW rises causes the transmitter to encode the pattern on D ₀₋₇ as a control code (Special Character), while a low causes the data to be coded using the 8B/10B alphabet. When MODE is high (placing the transmitter in Unencoded mode), SC/D acts as the D _a input. SC/D has the same timing as D ₀₋₇ .
SVS (D _i)	Send Violation Symbol (TTL Input). If SVS is high when CKW rises, a violation symbol is encoded and sent while the data on the parallel inputs is ignored. If SVS is low, the state of D ₀₋₇ and SC/D determines the code sent. In normal or TEST mode, this signal overrides the BIST (Built-In Self-Test) generator and forces the transmission of a violation code. When MODE is high (placing the receiver in Unencoded mode), SVS acts as the D _i input. SVS has the same timing as D ₀₋₇ .
EN \bar{A}	Enable Parallel Data (TTL input). If EN \bar{A} is low on the rising edge of CKW, the data appearing on D ₀₋₇ is loaded, encoded and sent. If EN \bar{A} and ENN are both high, the data inputs are ignored and the transmitter will insert a null character (K28.5) to fill the space between user data. EN \bar{A} may be held high/low continuously, or it may be pulsed with each data byte to be sent. If EN \bar{A} is being used for data control, ENN will normally be strapped high, but may be used for BIST function control.
ENN	Enable Next Parallel Data (TTL input). If ENN is low on the rising edge of CKW, the data appearing on D ₀₋₇ is loaded, encoded and sent. If EN \bar{A} and ENN are both high, the data inputs are ignored and the transmitter will insert a null character (K28.5) to fill the space between user data. ENN may be held high/low continuously, or it may be pulsed with each data byte to be sent. If ENN is being used for data control, EN \bar{A} will normally be strapped high, but may be used for BIST function control.
CKW	Clock Write (TTL input). CKW is both the clock frequency reference for the multiplying PLL the generates the high-speed transmit clock, and the byte rate write signal that synchronizes the parallel data input. CKW must be connected to a crystal controlled time base that runs within the specified frequency range of the transmitter.
FOTO	Fiber Optic Transmitter Off (TTL input). FOTO determines the function of two of the three PECL transmitter output pairs. If FOTO is low, the data encoded by the transmitter will appear at all three PECL output pairs continuously. If FOTO is high, OUTA \pm and OUTB \pm are forced to their "logical zero" state (OUT+ = low and OUT- = high) causing a fiber optic transmit module to extinguish its light output. OUTC \pm is unaffected by the level on FOTO, and can be used as a loop-back signal source for board-level diagnostic testing.

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OUTA OUTB OUTC	Differential Serial Data Outputs (differential PECL outputs). These PECL 100K outputs (+5 V referenced) are capable of driving terminated transmission lines or commercial fiber optic transmitter modules. Unused pairs of outputs can be wired to V_{CC} to reduce power if the output is not required. OUTA± and OUTB± are controlled by the level on FOTO, and will remain at their "logical zero" state when FOTO is asserted (high). OUTC± is unaffected by the level on FOTO. (OUTA+ and OUTB+ are used as a differential test clock input while in Test mode, i. e., MODE = unconnected or biased to $V_{CC}/2$).
MODE	Encoder Mode Select (3-level input). The level on the MODE input determines the encoding method to be used. When wired to GND, MODE selects 8B/10B encoding. When wired to V_{CC} , data inputs bypass the encoder and the bit patterns on D_{a-j} goes directly to the shifter. When left floating (internal resistors hold the MODE pin at $V_{CC}/2$ the internal bit clock generator is disabled and OUTA+/OUTB+ become the differential bit clock to be used for factory test. Intypical applications, MODE is wired to V_{CC} or GND.
BTSTEN	Built-In Self-Test Enable (TTL input) . When BTSTEN is low and ENN and ENA are both high, the transmitter sends alternating 1-0 pattern (D10.2 or D21.5). When either ENA or ENN is set low, and BTSTEN is low, the transmitter generates a repeating test sequence that allows the transmitter (working in conjunction with a receiver detecting BIST) to test the function of the entire link. In normal use this input is held high or wired to V_{CC} . The BIST generator is a free-running pattern generator that need not be initialized, but if required, the BIST sequence can be initialized by momentarily asserting SVS while BTSTEN is low. BTSTEN has the same timing as D_{0-7} .
RP	Read Pulse (TTL output). RP is a 60 %-low duty-cycle byte-rate pulse train suitable for the read pulse in 7C42x-style asynchronous FIFOs. The frequency on RP is the same as CKW when enabled by ENA, and the duty cycle is independent of the CKW duty cycle. Pulse widths are set by logic internal to the transmitter. In BIST mode, RP will remain high for all but the last byte of a test loop.
V_{CCN} , V_{CCQ}	Power supply. V_{CCN} and V_{CCQ} are +5.0 Volt nominal power supply pins. V_{CCN} provides power for the output drivers. V_{CCQ} provides power for the internal circuitry.
GND	Ground Pins. Power supply and signal ground.

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6.6 Sources of supply.

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6.6.1 Sources of supply for device classes Q and V. Sources of supply for device classes Q and V are listed in QML-38535. The vendors listed in QML-38535 have submitted a certificate of compliance (see 3.6 herein) to DSCC-VA and have agreed to this drawing.

6.6.2 Approved sources of supply for device class M. Approved sources of supply for class M are listed in MIL-HDBK-103. The vendors listed in MIL-HDBK-103 have agreed to this drawing and a certificate of compliance (see 3.6 herein) has been submitted to and accepted by DSCC-VA.

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STANDARD MICROCIRCUIT DRAWING BULLETIN

DATE: 97-05-06

Approved sources of supply for SMD 5962-96895 are listed below for immediate acquisition information only and shall be added to MIL-HDBK-103 during the next revision. MIL-HDBK-103 will be revised to include the addition or deletion of sources. The vendors listed below have agreed to this drawing and a certificate of compliance has been submitted to and accepted by DSCC-VA. This bulletin is superseded by the next dated revision of MIL-HDBK-103.

Standard microcircuit drawing PIN <u>1/</u>	Vendor CAGE number	Vendor similar PIN <u>2/</u>
5962-9689501Q3A	65786	CY7B923LMB

- 1/ The lead finish shown for each PIN representing a hermetic package is the most readily available from the manufacturer listed for that part. The device manufacturers listed herein are authorized to supply alternate lead finishes "A", "B", or "C" at their discretion. Contact the listed approved source of supply for further information.
- 2/ **Caution.** Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.

Vendor CAGE
number

65786

Vendor name
and address

Cypress Semiconductor
3901 N. First Street
San Jose, CA 95134

The information contained herein is disseminated for convenience only and the Government assumes no liability whatsoever for any inaccuracies in the information bulletin.